

Notice of References Cited	Application/Control No. 10/041,971	Applicant(s)/Patent Under Reexamination BISQUE ET AL.	
	Examiner Mylinh T Tran	Art Unit 2179	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,556,241	04-2003	Yoshimura et al.	348/211.99
	B	US-2002/0173877	11-2002	Zweig, Stephen Eliot	700/245
	C	US-5,971,068	10-1999	Ochiai et al.	165/290
	D	US-2003/0217100	11-2003	Kronk, David E.	709/203
	E	US-2004/0047036	03-2004	Baun et al.	359/430
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	60/105,626
	V	60/143,637
	W	
	X	

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